

10/072469



06/02

U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10072469	02/06/2002	359	639.000	2873	BEN

**APPLICANTS: Lange Steven;

**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A CIP OF 09/602,920 06/23/2000 PAT 6,362,923 BEN 2873
WHICH CLAIMS BENEFIT OF 60/188,309 03/10/2000

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** FOREIGN APPLICATIONS VERIFIED:

PG-PUB DO NOT PUBLISH ☐RESCIND ☐

Foreign priority claimed ☐ yes ☐ no
35 USC 119 conditions met ☐ yes ☐ no
Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO
KLA1P027X1

TITLE : Multi-detector microscopic inspection system

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G.
Assistant Examiner		DRAWING	
		Sheet Drwg.	Fig. Drwg. Print Fig.
Primary Examiner		Application Examiner	
PREPARED FOR ISSUE			
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